

JPW



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Group Art Unit: 2811
Examiner: Unassigned

In re PATENT APPLICATION of

Applicant : Teruhisa OBARA)
)
Appl. No. : 10/649,765)
)
Filed : August 28, 2003) **INFORMATION**
) **DISCLOSURE**
) **STATEMENT**
For : SEMICONDUCTOR INTEGRATED)
CIRCUIT WITH A TEST CIRCUIT)
)
Atty. Dkt. : OKI 368) _____

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

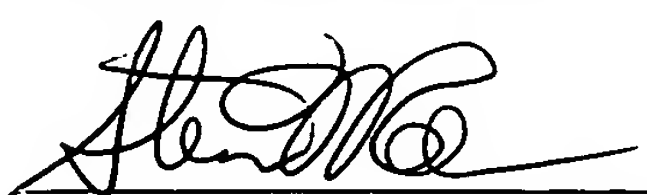
Sir:

This is an Information Disclosure Statement submitted in compliance with the timing requirements of 37 C.F.R. §1.97(b)(3), i.e., prior to a first Office Action on the merits.

Attached is a copy of a Japanese patent publication, which was cited in a Japanese Office Action dated March 30, 2004 that was issued by the Japanese Patent Office in connection with a Japanese counterpart application, together with the attached English-language translation and also an abstract. Since this Information Disclosure Statement is being filed before the first Office Action, no certification or fee is required, and the requirements of 37 C.F.R. §§1.97 and 1.98 are deemed to be fully met as to all documents listed. Consideration of the listed document is respectfully requested.

Should any fee be required, please charge the same to our Deposit Account No. 18-0002 and advise us accordingly.

Respectfully submitted,


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July 22, 2004
Date

SMR:pjl

FEE ENCLOSED: \$
Please charge any further
fee to our Deposit Account
No. 18-0002



FORM PTO-1449 INFORMATION DISCLOSURE STATEMENT		Atty Docket		Application No.			
		OKI 368		10/649,765			
		Applicant		Teruhisa OBARA			
		Filing Date		Group Unit			
		August 28, 2003		2811			
U.S. PATENT DOCUMENTS							
Examiner Initial		Document Number	Date	Name	Class	Sub-Class	Filing Date
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Sub-Class	Translation
	AI	2004-61340	2-26-04	Japan			yes
	AJ						
	AK						
	AL						
	AM						
	AN						
	AO						
OTHER (Including Author, Title, Date, Pertinent Pages, etc.)							
	AP						
	AQ						
	AR						
Examiner					Date Considered		
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.							